

Application/Control No.	Applicant(s)/Patent under Reexamination
10/801,204	TAN ET AL.
Examiner	Art Unit
LUONG T. NGUYEN	2622

	SEARCHED					
Class	Subclass	Date	Examiner			
348	243 272	9/5/2007	LN			
348	280 301	9/5/2007	LN			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
348/241,243,272,280,262,301; 250/208.1 (text search only, see search history printout)	9/5/2007	LN		
EAST (USPAT; US_PGPUB; JPO; EPO: DERWENT; TBM_TDB)see search history printout	9/5/2007	LN		